Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/712,876	PARK ET AL.	
Examiner	Art Unit	
B. Chen	1762	

	SEARCHED					
Class	Subclass	Date	Examiner			
427	255.29 255.31	3/4/2006	ВС			
<u>-</u>						

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
	 			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
		DATE	EXMR		
east		3/4/2006	ВС		
			·		